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U.S. DEPARTMENT COMMERCE PATENT AND TRADEWORK OFFICE LIST OF REFERENCES CITED BY MAN (S) (Use several sheets if necessary) Date submitted to the PTO: January 26, 2004				APPLICANT Tohru DEN, et al.	NO. 5 RECLIVE		
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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SPE		Masuda, "Metal nanohole array having high regularity formed of anodized alumina," KOTAIBUTSURI (Solid State Physics) 31, vol. 31, no. 5, pp. 493-499 (1996).										
SP	English-language translation of JP 11-200090.											
EXAMINER _	Sflu		DATE CONSIDERED	11/17/05								

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